Phosphole-based π -conjugated materials for OLEDs

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Table S1. Crystal data and structure refinement for derivative 3b after the 'squeeze' treatment.

molecular formula	C44 H39 Au Cl P		
molecular weight, g/mol	831.14		
a, Å	11.2536(9)		
b, Å	25.600(3)		
c, Å	13.7924(14)		
a, deg	90		
b, deg	98.022(3)		
g, deg	90		
V, Å ³	3934.6(7)		
Z	4		
D_{calc} , g cm ⁻³	1.403		
crystal system	Monoclinic		
space group	P21/n		
Т, К	100(2)		
wavelength Mo Ka, Å	0.71073		
m, mm ⁻¹	3.875		
<i>F</i> (000)	1656		
θ limit, deg	1.59 - 26.56		
no. reflns collected	31372		
no. ind reflns	8060		
reflections $[I > 2s(I)]$	6332		
data/restraints/parameters	8060 / 0 / 424		
GOF on F^2	1.036		
final R indices	R1 = 0.0461		
[I > 2s(I)]	wR2 = 0.1266		
largest diff peak	2.284		
and hole (e Å ⁻³)	2.284 -2.328		

Table S2. Crystal data and structure refinement for derivative 3b before the 'squeeze' treatment.

molecular formula	C45 H41 Au Cl3 P
molecular weight,	
g/mol	916.06
α, Å	11.2536(9)
β, Å	25.600(3)
χ, Å	13.7924(14)
α, deg	90
β, deg	98.022(3)
γ, deg	90
V, Å ³	3934.6(7)
Z	4
D_{calc} , g cm ⁻³	1.543
crystal system	Monoclinic
space group	P21/n
Т, К	100(2)
wavelength Mo Ka, Å	0.71073
μ , mm ⁻¹	4.014
<i>F</i> (000)	1824
θ limit, deg	1.59 - 26.56
no. reflns collected	31372
no. ind reflns	8060
reflections $[I > 2\sigma(I)]$	6323
data/restraints/parameters	8060 / 0 / 469
GOF on F ²	1.092
final R indices	R1 = 0.0524
$[I > 2\sigma(I)]$	wR2 = 0.1347
largest diff peak	2.175
and hole (e Å ⁻³)	-2.430

Compounds	E_{ox}/V^{a}	E_{ox}^{onset}/V	E_{red}/V^a	$E_{\rm red}^{\rm onset}/V$	HOMO/eV ^b	LUMO/eV ^c	DE^{EI}/eV^{d}
3 a	+ 1.47	+ 1.26	-1.55	- 1.47	- 5.66	- 2.93	2.73
3b	+ 1.37	+ 1.28	-1.58	- 1.51	- 5.68	- 2.89	2.79
4a	+ 1.38	+ 1.18	-1.60	- 1.47	- 5.58	- 2.93	2.65
4b	+ 1.32	+ 1.12	-1.56	- 1.52	- 5.52	- 2.88	2.64
Α	+ 1.95	+ 1.40	-1.64	- 1.60	- 5.80	- 2.80	3.00
В	+ 1.62	+ 1.37	-1.58	- 1.61	- 5.77	- 2.79	2.98

Table S3 : Electrochemical data for 3a,b, 4a,b and RAuCI/Rs (vs. SCE)

^{*a*}All potentials were obtained during cyclic voltametric investigations in 0.2 M Bu₄NPF₆ in CH₂Cl₂. Platinum electrode diameter 1 mm, sweep rate: 200 mV s⁻¹. ^{*b*} Calculated from the onset oxidation potential $\mathbb{E}_{out}^{\text{conset}/V}$. ^{*c*}Calculated from the onset reduction potential $\mathbb{E}_{out}^{\text{conset}/V}$.





Figure S2 EL spectra of the devices I-IV recorded at 30 mA/cm².







Figure S4 CIE coordinates of diodes I-IV.

Compounds	Diodes		$B_1^{a}/cd.m^{2}$	B ₁ ^b /cd.m ⁻²	
		1	28.4	21.1	
4a	111	2	23.6	17.0	
		3	26.2	20.6	
		1	120.1	114.3	
4b	IV	2	118.9	110.5	
		3	109.4	97.6	

 $^{^{\}rm a}$ brigthness at 1 mA, measured before IVL measurement; $^{\rm b}$ brigthness at 1 mA, measured after IVL measurement

Figure S5 Measurements of the Brigthness at 1 mA before and after IVL Characterizations